## Applicant(s)/Patent Under Reexamination Application/Control No. 10/696,397 LIN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 TUAN A. PHAM 2618

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0224771	12-2003	Nogueiro et al.	455/418
*	В	US-6,810,273	10-2004	Mattila et al.	455/570
	С	US-			
	D	US-			
	E	US-			·
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	j	US-			
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	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	. Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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